

APPENDIX C:
Probe Calibration Parameters

039929

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

Client
Kyocera USA

CALIBRATION CERTIFICATE

Object(s) **ET3DV6 - SN:1664**

Calibration procedure(s) **QA CAL-01 v2**
Calibration procedure for dosimetric E-field probes

Calibration date: **September 2, 2004**

Condition of the calibrated item **In Tolerance (according to the specific calibration document)**

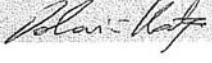
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature 22 +/- 2 degrees Celsius and humidity < 75%.

Calibration Equipment used (M&TE critical for calibration)

Model Type	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM E4419B	GB41293874	5-May-04 (METAS, No 251-00388)	May-05
Power sensor E4412A	MY41495277	5-May-04 (METAS, No 251-00388)	May-05
Reference 20 dB Attenuator	SN: 5086 (20b)	3-May-04 (METAS, No 251-00389)	May-05
Fluke Process Calibrator Type 702	SN: 6295803	8-Sep-03 (Slnrel SCS No. E030020)	Sep-04
Power sensor HP 8481A	MY41092180	18-Sep-02 (SPEAG, in house check Oct03)	In house check: Oct 05
RF generator HP 8684C	US3642U01700	4-Aug-99 (SPEAG, in house check Aug02)	In house check: Aug05
Network Analyzer HP 8753E	US37390585	18-Oct-01 (SPEAG, in house check Oct03)	In house check: Oct 05

Calibrated by:	Name Nico Vetterli	Function Technician	Signature 
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Approved by:	Katja Pokovic	Laboratory Director	
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Date issued: September 2, 2004

This calibration certificate is issued as an intermediate solution until the accreditation process (based on ISO/IEC 17025 International Standard) for Calibration Laboratory of Schmid & Partner Engineering AG is completed.

Probe ET3DV6

SN:1664

Manufactured:	February 8, 2002
Last calibrated:	August 29, 2003
Repaired:	August 25, 2004
Recalibrated:	September 2, 2004

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

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DASY - Parameters of Probe: ET3DV6 SN:1664

Sensitivity in Free Space

NormX	1.89 $\mu\text{V}/(\text{V}/\text{m})^2$
NormY	1.82 $\mu\text{V}/(\text{V}/\text{m})^2$
NormZ	1.66 $\mu\text{V}/(\text{V}/\text{m})^2$

Diode Compression^A

DCP X	96	mV
DCP Y	96	mV
DCP Z	96	mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 7.

Boundary Effect

Head 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance	3.7 mm	4.7 mm
SAR _{be} [%] Without Correction Algorithm	9.0	4.6
SAR _{be} [%] With Correction Algorithm	0.1	0.3

Head 1800 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance	3.7 mm	4.7 mm
SAR _{be} [%] Without Correction Algorithm	13.0	8.7
SAR _{be} [%] With Correction Algorithm	0.1	0.1

Sensor Offset

Probe Tip to Sensor Center	2.7 mm
Optical Surface Detection	in tolerance

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

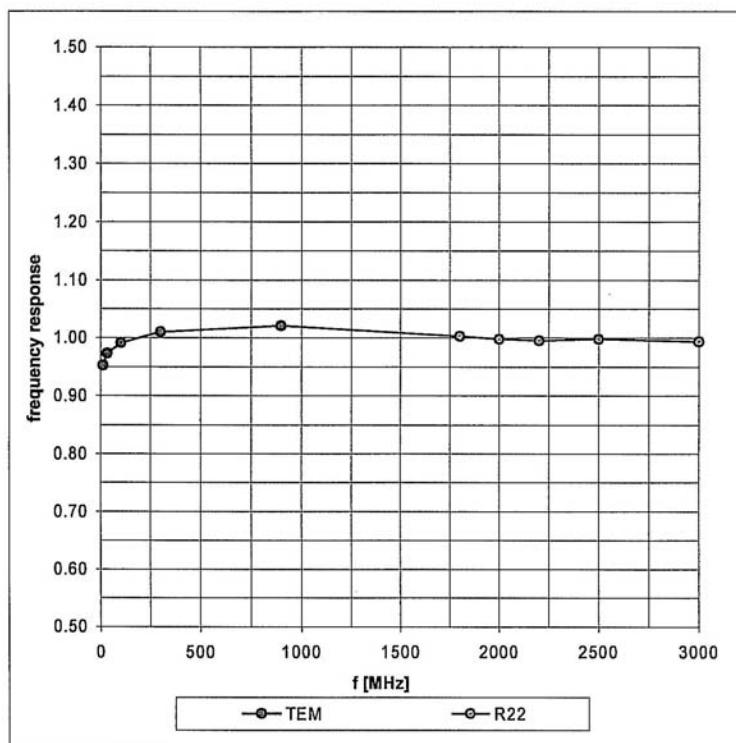
^A numerical linearization parameter: uncertainty not required

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Frequency Response of E-Field

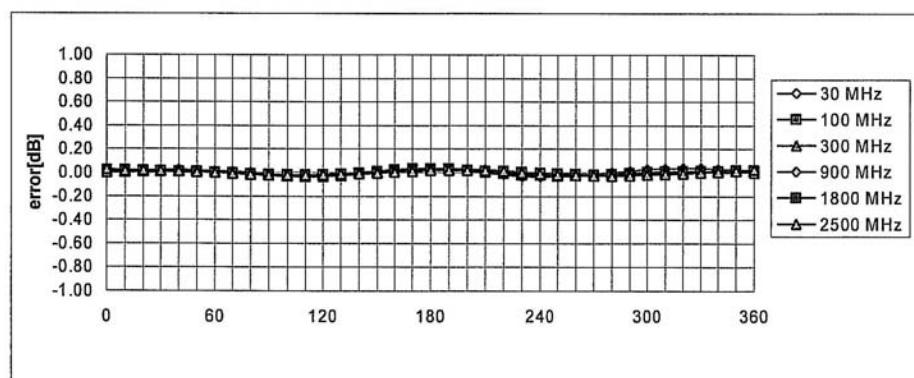
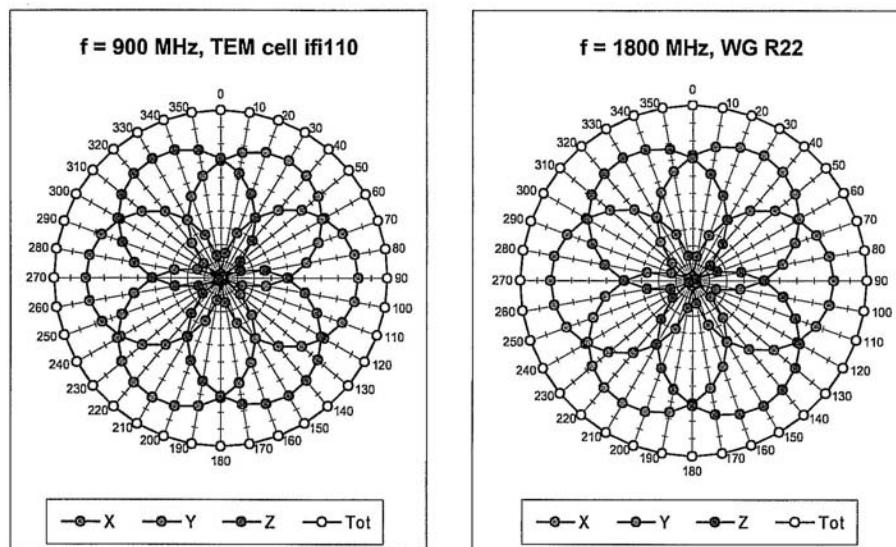
(TEM-Cell:ifi110, Waveguide R22)



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Receiving Pattern (ϕ), $\theta = 0^\circ$

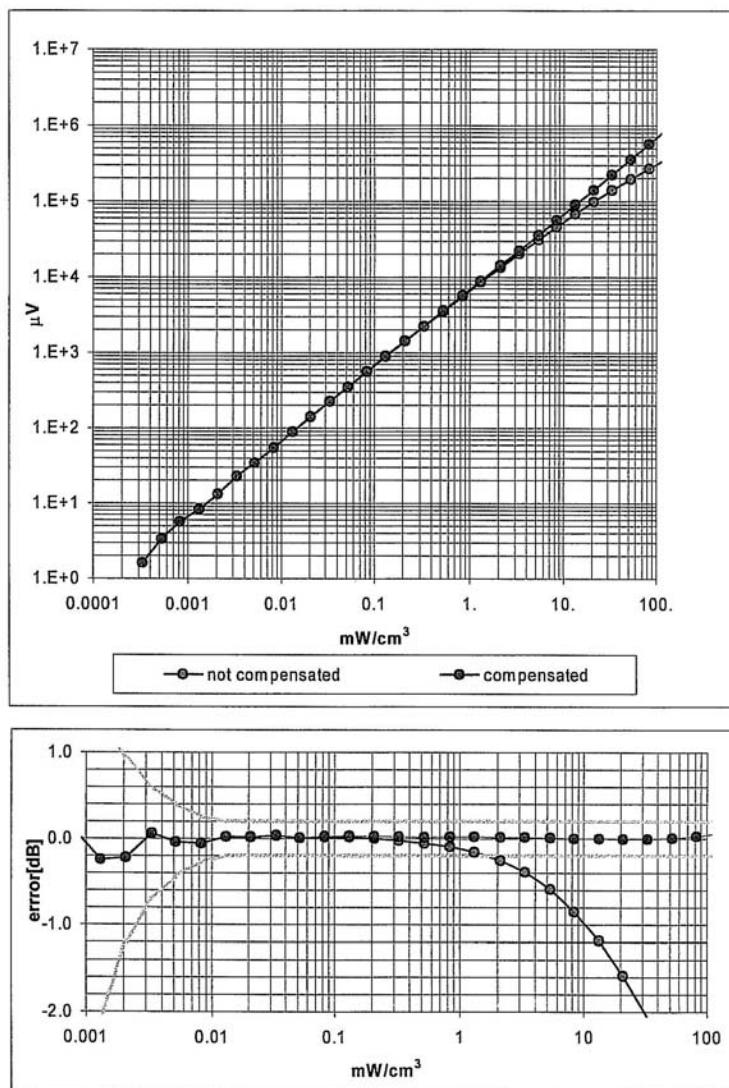


Axial Isotropy Error $< \pm 0.2$ dB

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Dynamic Range f(SAR_{head}) (Waveguide R22)

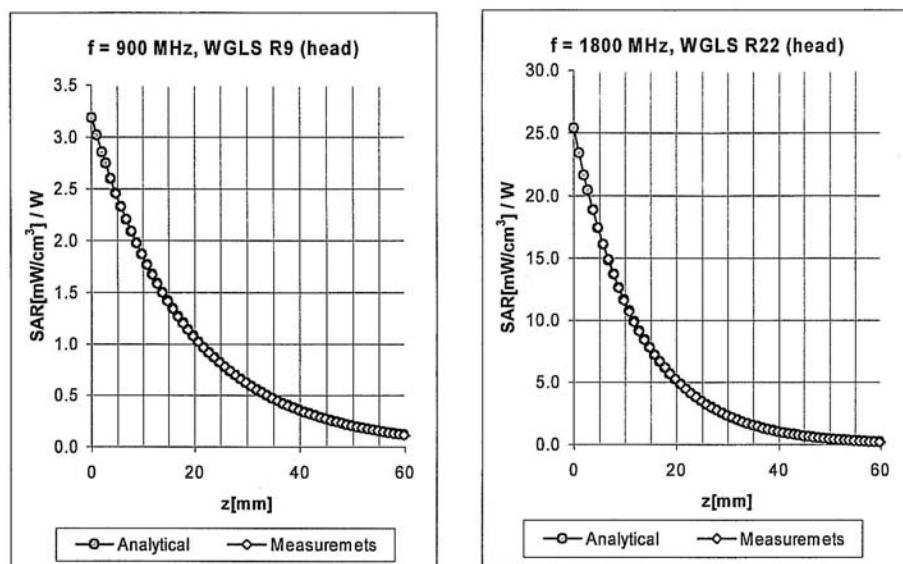


Probe Linearity Error < ± 0.2 dB

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Conversion Factor Assessment



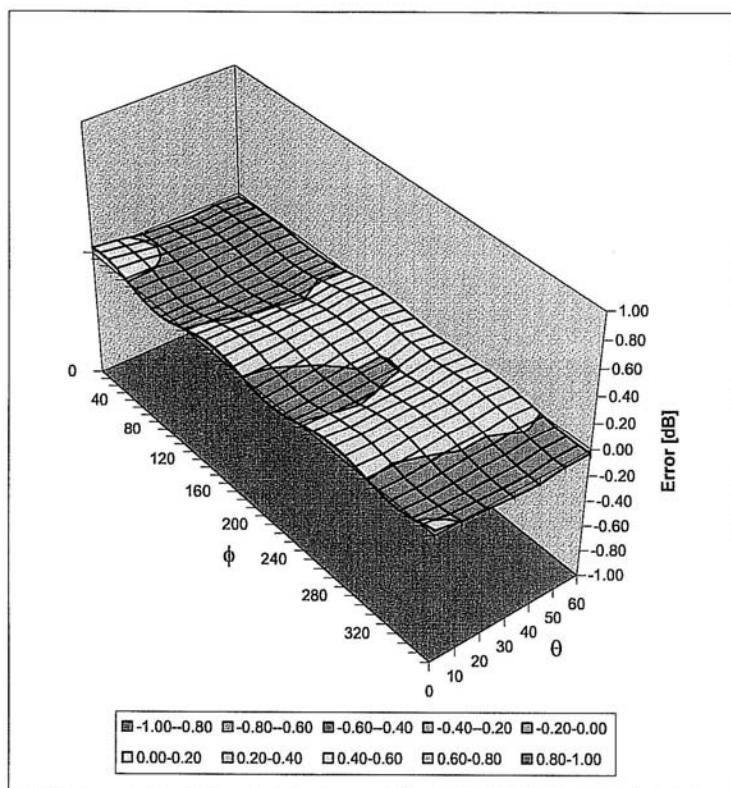
f [MHz]	Validity [MHz] ^B	Tissue	Permittivity	Conductivity	Alpha	Depth	ConvF	Uncertainty
900	800-1000	Head	$41.5 \pm 5\%$	$0.97 \pm 5\%$	0.64	1.80	6.56	$\pm 11.3\% (k=2)$
1800	1710-1910	Head	$40.0 \pm 5\%$	$1.40 \pm 5\%$	0.48	2.61	5.43	$\pm 11.7\% (k=2)$

900	800-1000	Body	$55.0 \pm 5\%$	$1.05 \pm 5\%$	0.52	2.11	6.17	$\pm 11.3\% (k=2)$
1800	1710-1910	Body	$53.3 \pm 5\%$	$1.52 \pm 5\%$	0.55	2.73	4.72	$\pm 11.7\% (k=2)$

^B The total standard uncertainty is calculated as root-sum-square of standard uncertainty of the Conversion Factor at calibration frequency and the standard uncertainty for the indicated frequency band.

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Deviation from Isotropy in HSLError (θ, ϕ), f = 900 MHz**Spherical Isotropy Error < ± 0.4 dB**

Schmid & Partner Engineering AG

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 info@speag.com, http://www.speag.com
CUSTOMER COPY**PROBE REPAIR REPORT – SPEAG Production Center**

PRODUCT: ET3DV6 Probe				
SERIAL Nr.: 1664	IN DATE: 23-Aug-2004			
CUSTOMER: Kyocera USA				
PROBE REPAIR	WORK DESCRIPTION		WORKING TIME (h)	
	Proximity Sensor (PEEK)	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Core replacement:	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Dipole sensor:	fixed <input type="checkbox"/> exchanged <input type="checkbox"/>	 <input type="checkbox"/>
	Substrate:	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Components (diodes)	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Components (capacitors)	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Bonding R-lines - substrate	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Probe tip:	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Probe connector:	fixed <input type="checkbox"/> exchanged <input checked="" type="checkbox"/>	 <input type="checkbox"/>
	Probe tube	fixed <input type="checkbox"/> exchanged <input type="checkbox"/>	 <input type="checkbox"/>
	Analasys:		 <input type="checkbox"/>
Final Assembly:		 <input type="checkbox"/>	
Total hours			13.00 hours	
COMMENTS:		After the probe was opened, glycol was found inside the probe. This Glycol has damaged the electronic components inside the probe and softened the bonding. The complete core including all components were exchanged and the probe re assembled with a new proximity sensor and a new probe tip.		
CONDUCTED BY:	<u>I.V. Blumer</u>	APPROVED BY:	<u>Blumer</u>	
DATE:	<u>25. Aug 04</u>	DATE:	<u>26. Aug 04</u>	
REPAIR COST:				
MATERIAL COST:	<u>1965.00</u>	USD <input checked="" type="checkbox"/>	Euro <input type="checkbox"/>	
REPAIR:	<u>1950.00</u>	<input checked="" type="checkbox"/>	<input type="checkbox"/>	
TOTAL COST:	<u>S+M</u>	QUOTATION #: <u>/</u>		
APPROVED BY:		<u>P. Kast</u>		
DATE:	<u>27. Aug 04</u>			
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